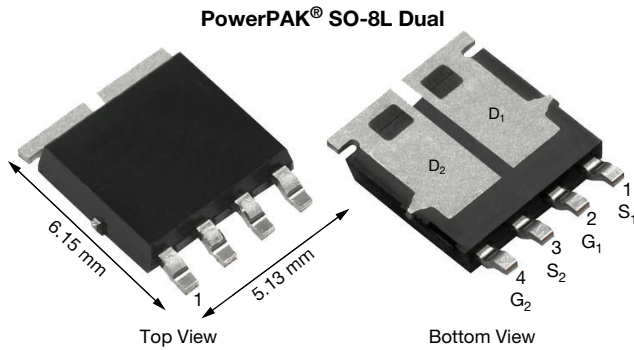


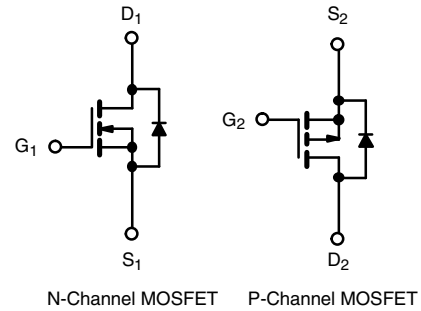
Automotive N- and P-Channel 40 V (D-S) 175 °C MOSFET



FEATURES

- TrenchFET® power MOSFET
- AEC-Q101 qualified
- 100 % R_G and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

AUTOMOTIVE GRADE


RoHS
 COMPLIANT
 HALOGEN
FREE


PRODUCT SUMMARY		
	N-CHANNEL	P-CHANNEL
V _{DS} (V)	40	-40
R _{DS(on)} (Ω) at V _{GS} = ± 10 V	0.0075	0.0170
R _{DS(on)} (Ω) at V _{GS} = ± 4.5 V	0.0110	0.0230
I _D (A)	30	-30
Configuration	N- and p-pair	
Package	PowerPAK SO-8L Dual	

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	N-CHANNEL	P-CHANNEL	UNIT
Drain-source voltage		V _{DS}	40	-40	V
Gate-source voltage		V _{GS}	± 20		
Continuous drain current	T _C = 25 °C	I _D	30 ^a	-30 ^a	A
	T _C = 125 °C		29.3	-19.5	
Continuous source current (diode conduction) ^a		I _S	30	-30	
Pulsed drain current ^b		I _{DM}	90	-84	
Single pulse avalanche current	L = 0.1 mH	I _{AS}	25	-24	mJ
Single pulse avalanche Energy			E _{AS}	31.2	
Maximum power dissipation ^b	T _C = 25 °C	P _D	34	34	W
	T _C = 125 °C		11	11	
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +175		°C
Soldering recommendations (peak temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	N-CHANNEL	P-CHANNEL	UNIT
Junction-to-ambient	PCB mount ^c	R _{thJA}	85	85	°C/W
Junction-to-case (drain)		R _{thJC}	4.3	4.3	

Notes

- Package limited
- Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2 %
- When mounted on 1" square PCB (FR4 material)
- See solder profile (www.vishay.com/doc?73257). The PowerPAK SO-8L is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components



SPECIFICATIONS ($T_C = 25\text{ }^\circ\text{C}$, unless otherwise noted)								
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static								
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$		N-Ch	40	-	-	V
		$V_{GS} = 0\text{ V}, I_D = -250\text{ }\mu\text{A}$		P-Ch	-40	-	-	
Gate-source threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$		N-Ch	1.5	2	2.5	V
		$V_{DS} = V_{GS}, I_D = -250\text{ }\mu\text{A}$		P-Ch	-1.5	-2	-2.5	
Gate-source leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$		N-Ch	-	-	± 100	nA
				P-Ch	-	-	± 100	
Zero gate voltage drain current	I_{DSS}	$V_{GS} = 0\text{ V}$	$V_{DS} = 40\text{ V}$	N-Ch	-	-	1	μA
		$V_{GS} = 0\text{ V}$	$V_{DS} = -40\text{ V}$	P-Ch	-	-	-1	
		$V_{GS} = 0\text{ V}$	$V_{DS} = 40\text{ V}, T_J = 125\text{ }^\circ\text{C}$	N-Ch	-	-	50	
		$V_{GS} = 0\text{ V}$	$V_{DS} = -40\text{ V}, T_J = 125\text{ }^\circ\text{C}$	P-Ch	-	-	-50	
		$V_{GS} = 0\text{ V}$	$V_{DS} = 40\text{ V}, T_J = 175\text{ }^\circ\text{C}$	N-Ch	-	-	150	
		$V_{GS} = 0\text{ V}$	$V_{DS} = -40\text{ V}, T_J = 175\text{ }^\circ\text{C}$	P-Ch	-	-	-150	
On-state drain current ^a	$I_{D(on)}$	$V_{GS} = 10\text{ V}$	$V_{DS} \geq 5\text{ V}$	N-Ch	10	-	-	A
		$V_{GS} = -10\text{ V}$	$V_{DS} \leq 5\text{ V}$	P-Ch	-10	-	-	
Drain-source on-state resistance ^a	$R_{DS(on)}$	$V_{GS} = 10\text{ V}$	$I_D = 8\text{ A}$	N-Ch	-	0.0061	0.0075	Ω
		$V_{GS} = -10\text{ V}$	$I_D = -8\text{ A}$	P-Ch	-	0.0138	0.0170	
		$V_{GS} = 10\text{ V}$	$I_D = 8\text{ A}, T_J = 125\text{ }^\circ\text{C}$	N-Ch	-	-	0.0110	
		$V_{GS} = -10\text{ V}$	$I_D = -8\text{ A}, T_J = 125\text{ }^\circ\text{C}$	P-Ch	-	-	0.0254	
		$V_{GS} = 10\text{ V}$	$I_D = 8\text{ A}, T_J = 175\text{ }^\circ\text{C}$	N-Ch	-	-	0.0130	
		$V_{GS} = -10\text{ V}$	$I_D = -8\text{ A}, T_J = 175\text{ }^\circ\text{C}$	P-Ch	-	-	0.0304	
		$V_{GS} = 4.5\text{ V}$	$I_D = 5\text{ A}$	N-Ch	-	0.0088	0.0110	
		$V_{GS} = -4.5\text{ V}$	$I_D = -5\text{ A}$	P-Ch	-	0.0186	0.0230	
Forward transconductance ^b	g_{fs}	$V_{DS} = 15\text{ V}, I_D = 8\text{ A}$		N-Ch	-	35	-	S
		$V_{DS} = -15\text{ V}, I_D = -8\text{ A}$		P-Ch	-	30	-	
Dynamic ^b								
Input capacitance	C_{iss}	$V_{GS} = 0\text{ V}$	$V_{DS} = 25\text{ V}, f = 1\text{ MHz}$	N-Ch	-	1355	1900	μF
		$V_{GS} = 0\text{ V}$	$V_{DS} = -25\text{ V}, f = 1\text{ MHz}$	P-Ch	-	3340	4600	
Output capacitance	C_{oss}	$V_{GS} = 0\text{ V}$	$V_{DS} = 25\text{ V}, f = 1\text{ MHz}$	N-Ch	-	875	1400	pF
		$V_{GS} = 0\text{ V}$	$V_{DS} = -25\text{ V}, f = 1\text{ MHz}$	P-Ch	-	230	320	
Reverse transfer capacitance	C_{rss}	$V_{GS} = 0\text{ V}$	$V_{DS} = 25\text{ V}, f = 1\text{ MHz}$	N-Ch	-	35	50	pF
		$V_{GS} = 0\text{ V}$	$V_{DS} = -25\text{ V}, f = 1\text{ MHz}$	P-Ch	-	216	300	
Total gate charge ^c	Q_g	$V_{GS} = 10\text{ V}$	$V_{DS} = 20\text{ V}, I_D = 5\text{ A}$	N-Ch	-	18	30	nC
		$V_{GS} = -10\text{ V}$	$V_{DS} = -20\text{ V}, I_D = -5\text{ A}$	P-Ch	-	56	85	
Gate-source charge ^c	Q_{gs}	$V_{GS} = 10\text{ V}$	$V_{DS} = 20\text{ V}, I_D = 5\text{ A}$	N-Ch	-	3.5	-	nC
		$V_{GS} = -10\text{ V}$	$V_{DS} = -20\text{ V}, I_D = -5\text{ A}$	P-Ch	-	8.5	-	
Gate-drain charge ^c	Q_{gd}	$V_{GS} = 10\text{ V}$	$V_{DS} = 20\text{ V}, I_D = 5\text{ A}$	N-Ch	-	2.6	-	nC
		$V_{GS} = -10\text{ V}$	$V_{DS} = -20\text{ V}, I_D = -5\text{ A}$	P-Ch	-	9.9	-	
Gate resistance	R_g	$f = 1\text{ MHz}$		N-Ch	0.3	0.72	1.2	Ω
				P-Ch	1.15	2.37	3.6	



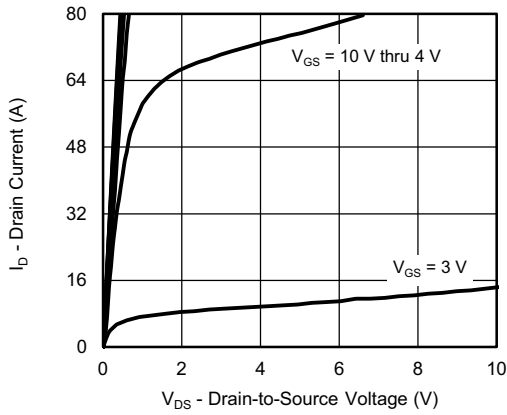
SPECIFICATIONS (T _C = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Turn-on delay time ^c	t _{d(on)}	V _{DD} = 20 V, R _L = 4 Ω, I _D ≅ 5 A, V _{GEN} = 10 V, R _g = 1 Ω	N-Ch	-	11	20	ns
		V _{DD} = -20 V, R _L = 4 Ω, I _D ≅ -5 A, V _{GEN} = -10 V, R _g = 1 Ω	P-Ch	-	15	25	
Rise time ^c	t _r	V _{DD} = 20 V, R _L = 4 Ω, I _D ≅ 5 A, V _{GEN} = 10 V, R _g = 1 Ω	N-Ch	-	4	10	
		V _{DD} = -20 V, R _L = 4 Ω, I _D ≅ -5 A, V _{GEN} = -10 V, R _g = 1 Ω	P-Ch	-	6	10	
Turn-off delay time ^c	t _{d(off)}	V _{DD} = 20 V, R _L = 4 Ω, I _D ≅ 5 A, V _{GEN} = 10 V, R _g = 1 Ω	N-Ch	-	21	35	
		V _{DD} = -20 V, R _L = 4 Ω, I _D ≅ -5 A, V _{GEN} = -10 V, R _g = 1 Ω	P-Ch	-	45	70	
Fall time ^c	t _f	V _{DD} = 20 V, R _L = 4 Ω, I _D ≅ 5 A, V _{GEN} = 10 V, R _g = 1 Ω	N-Ch	-	5	10	
		V _{DD} = -20 V, R _L = 4 Ω, I _D ≅ -5 A, V _{GEN} = -10 V, R _g = 1 Ω	P-Ch	-	7	12	
Source-Drain Diode Ratings and Characteristics ^b							
Pulsed current ^a	I _{SM}		N-Ch	-	-	90	A
			P-Ch	-	-	-84	
Forward voltage	V _{SD}	I _S = 8 A, V _{GS} = 0 V	N-Ch	-	0.803	1.2	V
		I _S = -8 A, V _{GS} = 0 V	P-Ch	-	-0.790	-1.2	
Body diode reverse recovery time	t _{rr}	I _F = 5 A, di/dt = 100 A/μs	N-Ch	-	48	100	ns
		I _F = -5 A, di/dt = 100 A/μs	P-Ch	-	26	55	
Body diode reverse recovery charge	Q _{rr}	I _F = 5 A, di/dt = 100 A/μs	N-Ch	-	54	110	nC
		I _F = -5 A, di/dt = 100 A/μs	P-Ch	-	22	45	
Reverse recovery fall time	t _a	I _F = 5 A, di/dt = 100 A/μs	N-Ch	-	25	-	ns
		I _F = -5 A, di/dt = 100 A/μs	P-Ch	-	15	-	
Reverse recovery rise time	t _b	I _F = 5 A, di/dt = 100 A/μs	N-Ch	-	23	-	ns
		I _F = -5 A, di/dt = 100 A/μs	P-Ch	-	11	-	
Body diode peak reverse recovery current	I _{RM(REC)}	I _F = 5 A, di/dt = 100 A/μs	N-Ch	-	-2.1	-	A
		I _F = -5 A, di/dt = 100 A/μs	P-Ch	-	-1.7	-	

Notes

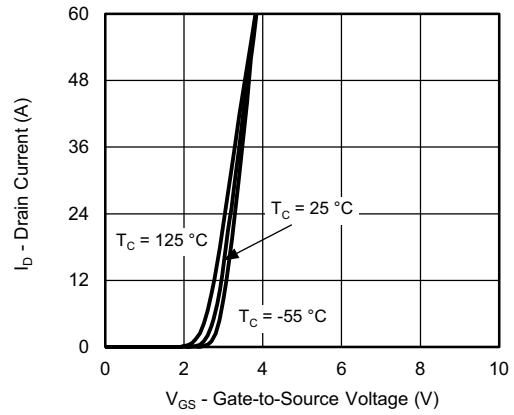
- a. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2 %
- b. Guaranteed by design, not subject to production testing
- c. Independent of operating temperature

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

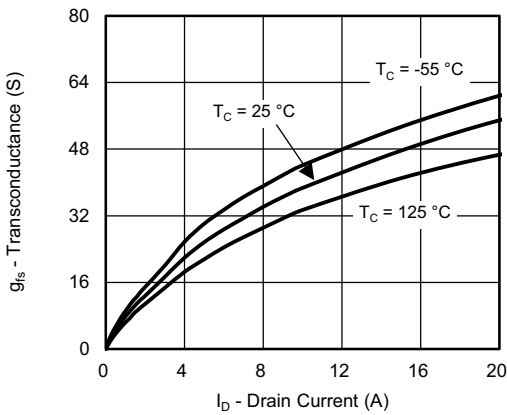
N-CHANNEL TYPICAL CHARACTERISTICS ($T_A = 25\text{ }^\circ\text{C}$, unless otherwise noted)



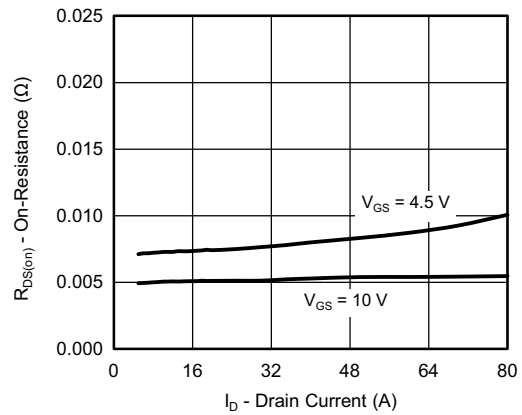
Output Characteristics



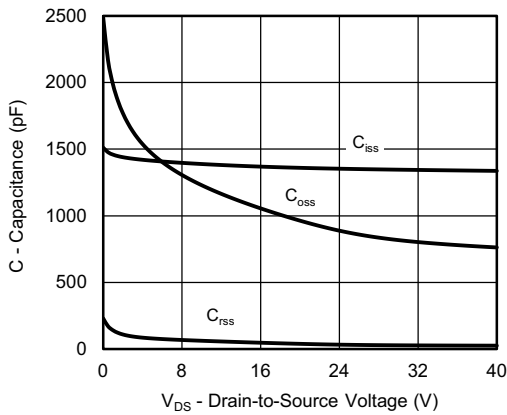
Transfer Characteristics



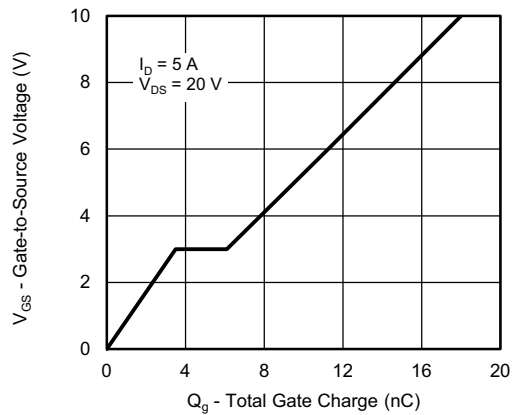
Transconductance



On-Resistance vs. Drain Current



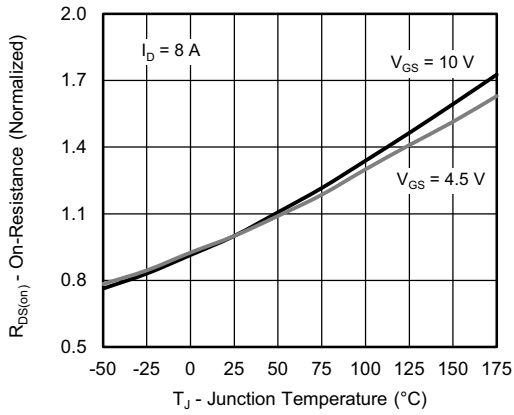
Capacitance



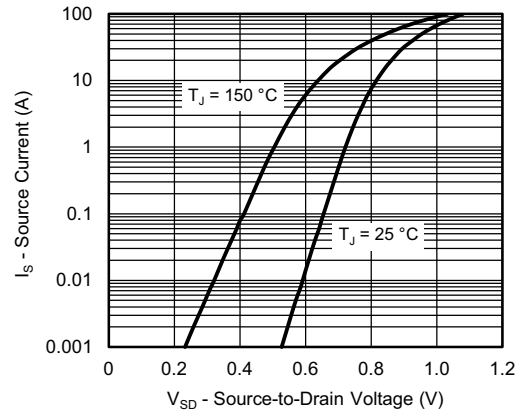
Gate Charge



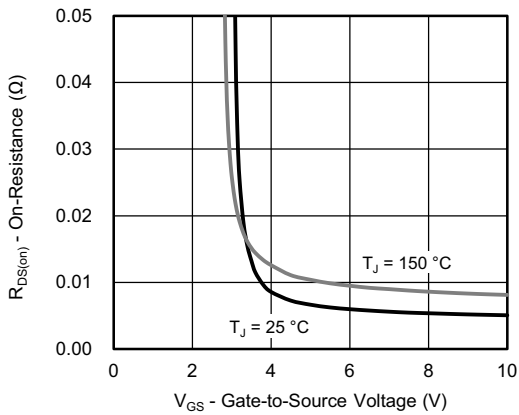
N-CHANNEL TYPICAL CHARACTERISTICS ($T_A = 25\text{ }^\circ\text{C}$, unless otherwise noted)



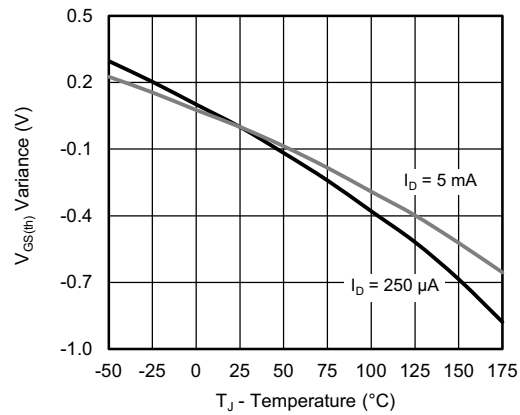
On-Resistance vs. Junction Temperature



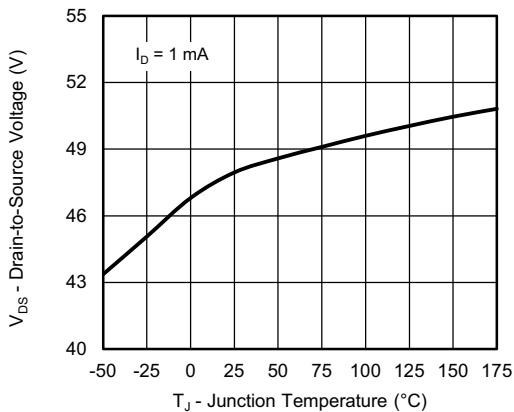
Source Drain Diode Forward Voltage



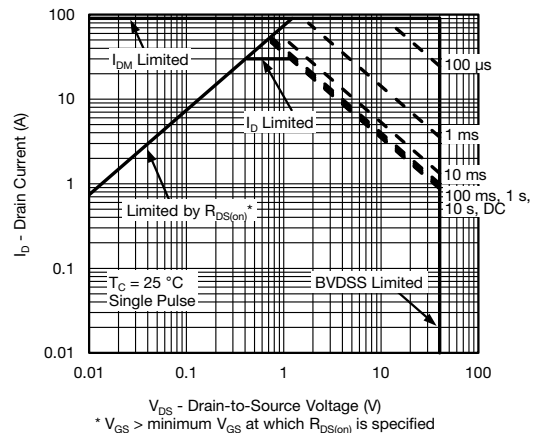
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

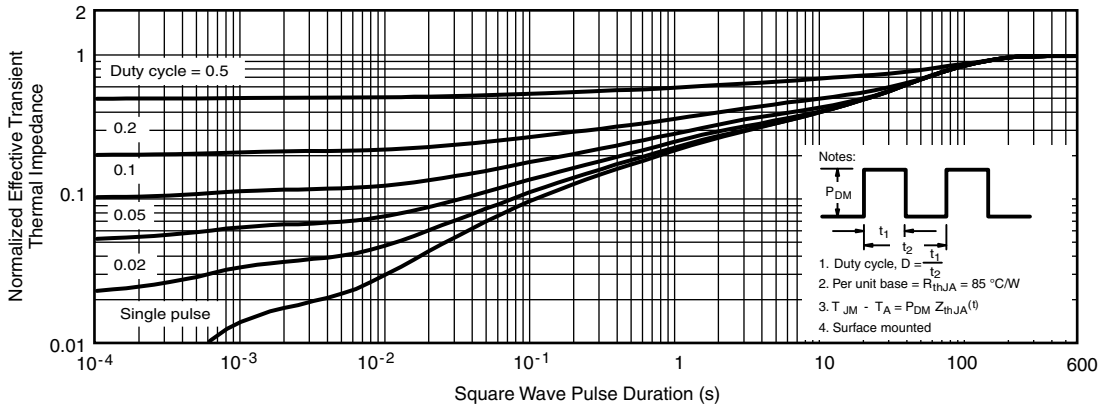


Drain Source Breakdown vs. Junction Temperature

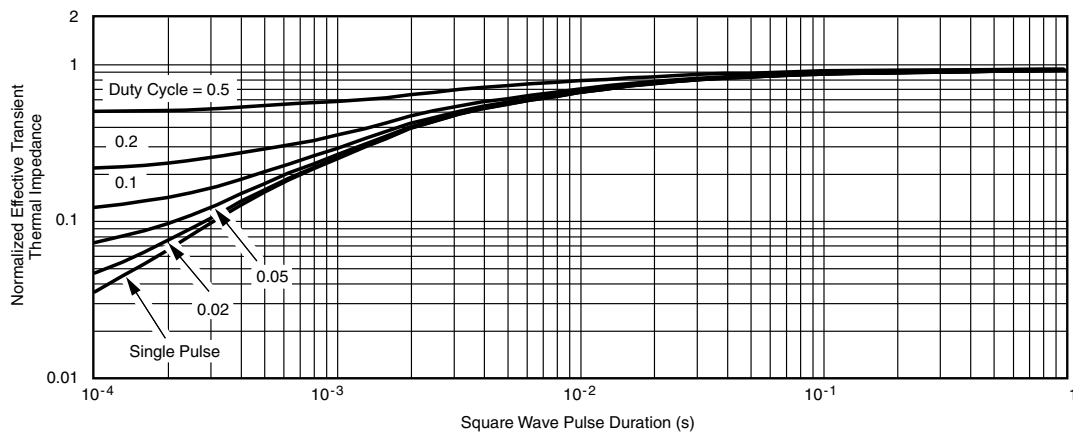


Safe Operating Area

N-CHANNEL TYPICAL CHARACTERISTICS ($T_A = 25\text{ }^\circ\text{C}$, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



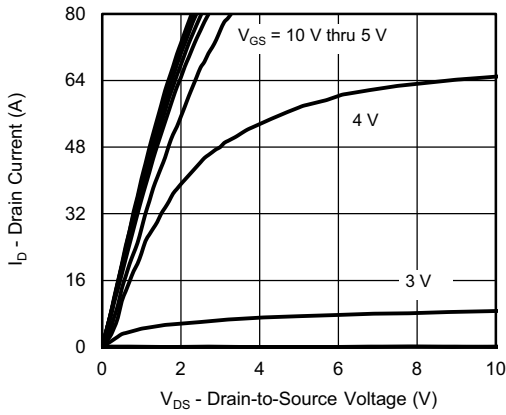
Normalized Thermal Transient Impedance, Junction-to-Case

Note

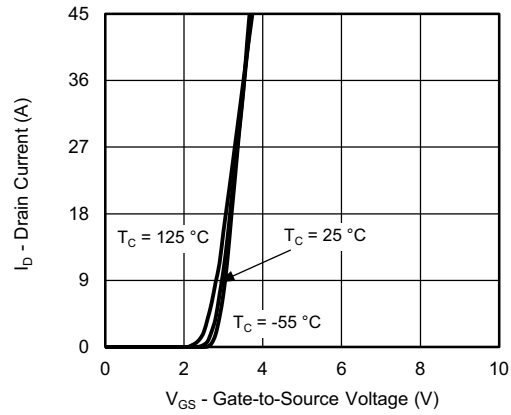
- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction-to-Ambient ($25\text{ }^\circ\text{C}$)
 - Normalized Transient Thermal Impedance Junction-to-Case ($25\text{ }^\circ\text{C}$)
 are given for general guidelines only to enable the user to get a “ball park” indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions



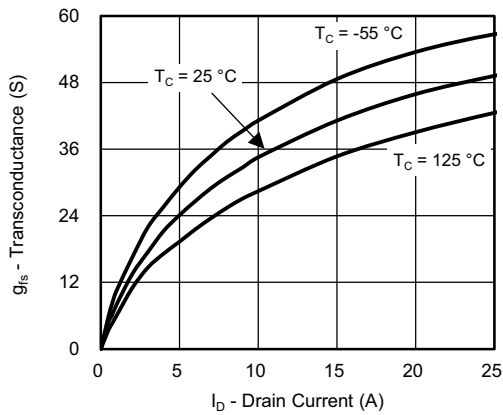
P-CHANNEL TYPICAL CHARACTERISTICS ($T_A = 25\text{ }^\circ\text{C}$, unless otherwise noted)



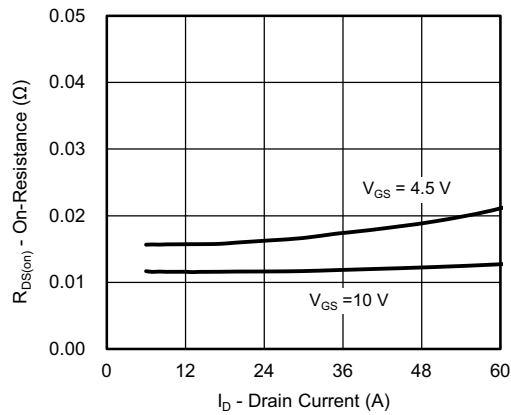
Output Characteristics



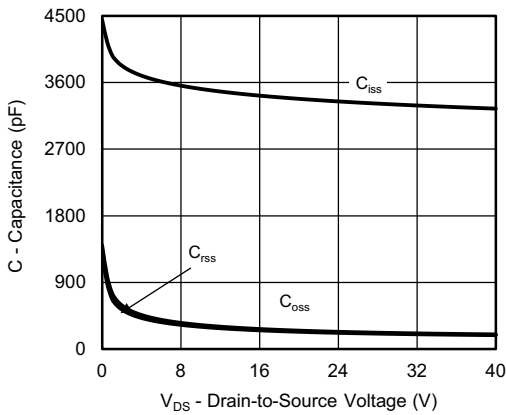
Transfer Characteristics



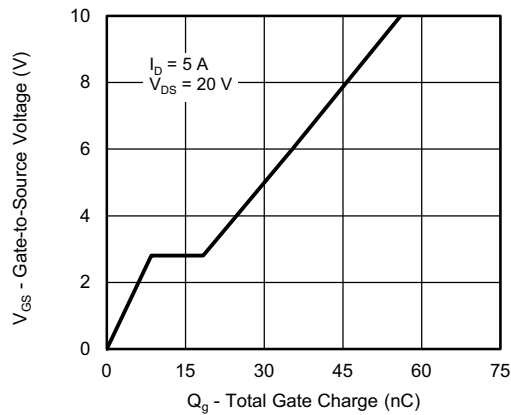
Transconductance



On-Resistance vs. Drain Current

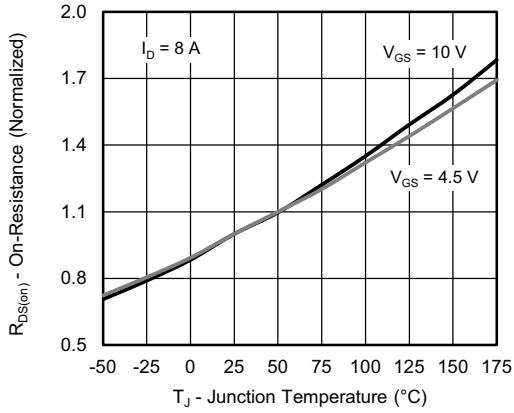


Capacitance

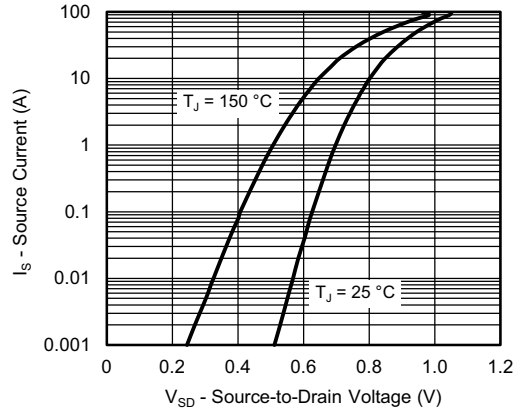


Gate Charge

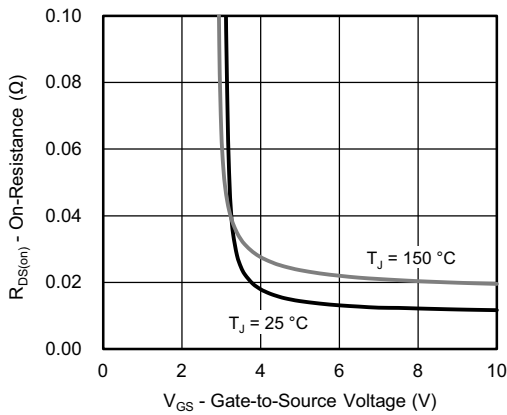
P-CHANNEL TYPICAL CHARACTERISTICS ($T_A = 25\text{ }^\circ\text{C}$, unless otherwise noted)



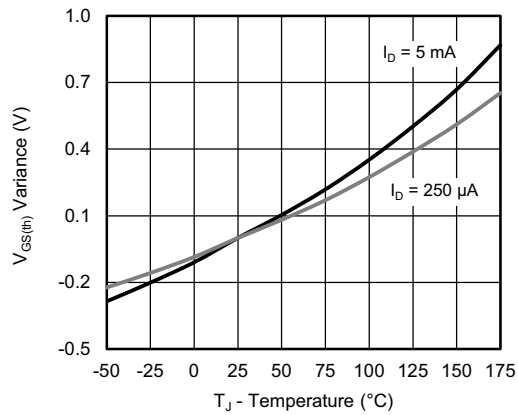
Threshold Voltage



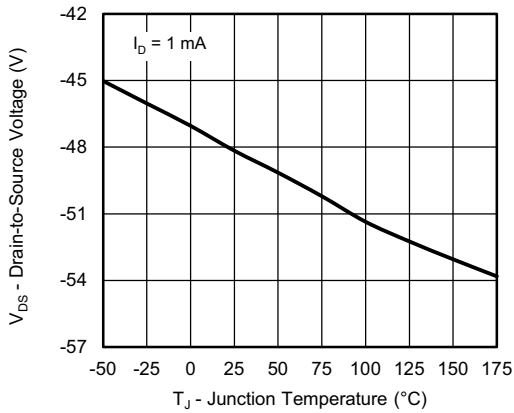
Source Drain Diode Forward Voltage



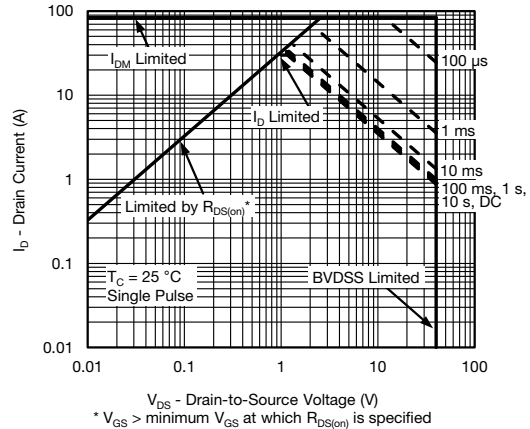
On-Resistance vs. Gate-to-Source Voltage



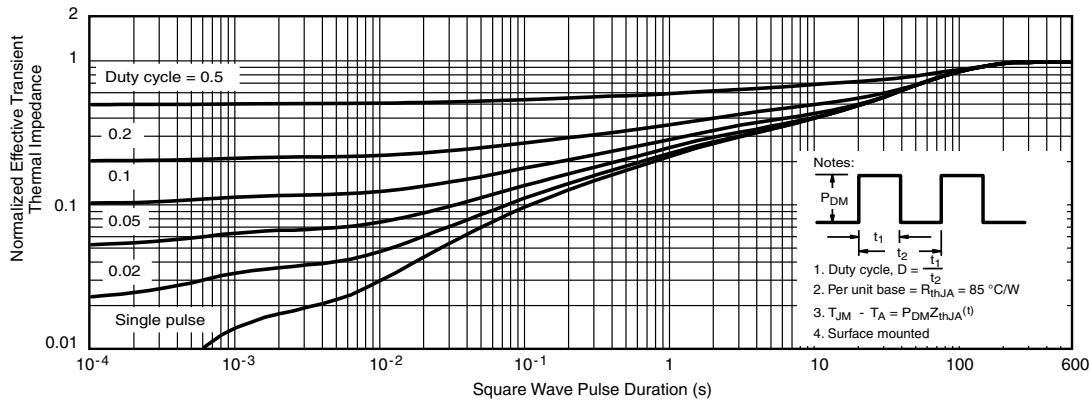
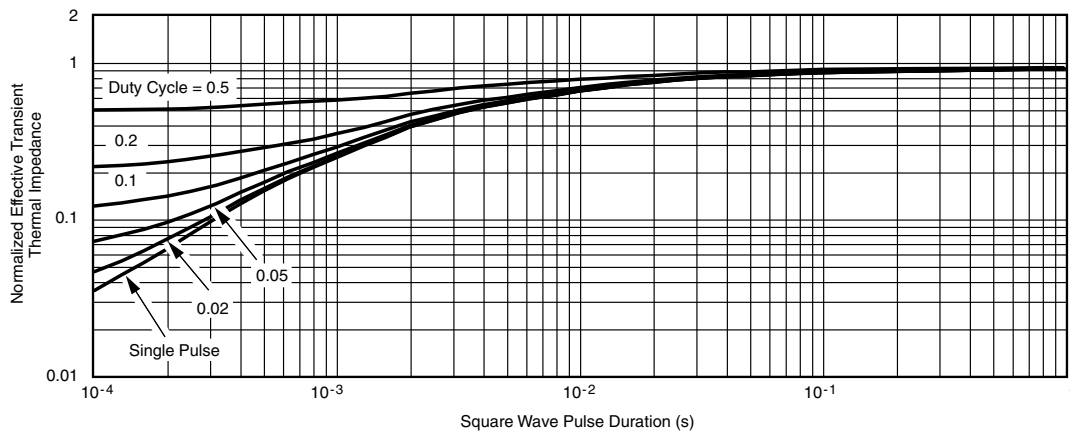
Threshold Voltage



Drain Source Breakdown vs. Junction Temperature



Safe Operating Area

P-CHANNEL TYPICAL CHARACTERISTICS ($T_A = 25\text{ }^\circ\text{C}$, unless otherwise noted)

Normalized Thermal Transient Impedance, Junction-to-Ambient

Normalized Thermal Transient Impedance, Junction-to-Case
Note

- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction-to-Ambient ($25\text{ }^\circ\text{C}$)
 - Normalized Transient Thermal Impedance Junction-to-Case ($25\text{ }^\circ\text{C}$)
 are given for general guidelines only to enable the user to get a “ball park” indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions

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